



P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
-20V	$54m\Omega$ @ V_{GS} = $-4.5V$	-2.5A
-20 V	$90m\Omega$ @ V_{GS} = -1.8 V	-1.8A

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- · Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Up To 3kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

Description and Applications

This MOSFET has been designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- Power Management Functions
- DC-DC Converters

Mechanical Data

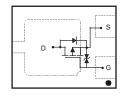
- Case: X2-DFN2015-3
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208 @4
- Terminals Connections: See Diagram Below
- Weight: 0.008 grams (approximate)

X2-DFN2015-3









Top View

Bottom View

Internal Schematic

Ordering Information (Note 4 & 5)

Part Number	Compliance	Case	Packaging
DMP2069UFY4Q-7	Automotive	X2-DFN2015-3	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www.diodes.com/quality/product_grade_definitions/.
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

• 29P YM 29P = Marking Code YM = Date Code Marking Y = Year (ex: W = 2009) M = Month (ex: 9 = September)

Date Code Key

Date Code Ney												
Year	200	9	2010		2011	20)12	2013		2014		2015
Code	W		X		Υ		Z	Α		В		С
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	Ν	D



Maximum Ratings @TA = 25°C unless otherwise specified

Characte	eristic		Symbol	Value	Units
Drain-Source Voltage			V _{DSS}	-20	V
Gate-Source Voltage		V _{GSS}	±8	V	
Continuous Drain Current (Note 6)	Steady State	T _A = +25°C T _A = +70°C	I _D	-2.5 -2.2	А
Pulsed Drain Current (Note 7)			I _{DM}	-12	А

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 6)	P _D	0.53	W
Thermal Resistance, Junction to Ambient @T _A = +25°C	R _{0JA}	231	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

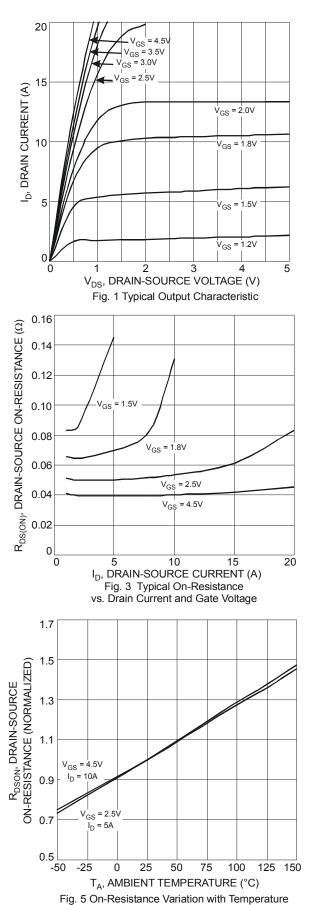
Electrical Characteristics @TA = +25°C unless otherwise specified

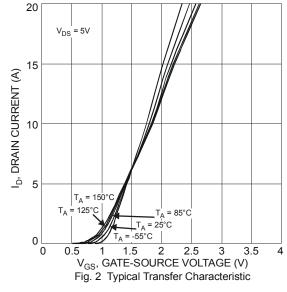
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	-20	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	-1.0	μA	V _{DS} = -20V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 8V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(th)}	-0.3	-0.55	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
			36	54		V_{GS} = -4.5V, I_D = -2.5A	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	46	69	mΩ	$V_{GS} = -2.5V$, $I_D = -2.2A$	
			60	90		V_{GS} = -1.8V, I_{D} = -2.0A	
Forward Transfer Admittance	Y _{fs}	_	8	_	S	V _{DS} = -5V, I _D = -2.5A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}		214	_	pF		
Output Capacitance	Coss	_	104	_	pF	$V_{DS} = -10V, V_{GS} = 0V$ -f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	25	_	pF	1 - 1.01/11/2	
Gate Resistnace	R_g	_	250	_	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz	
SWITCHING CHARACTERISTICS (Note 9)							
Total Gate Charge	Qg	_	9.1	_	nC		
Gate-Source Charge	Q_{gs}	_	1.5	_	nC	$V_{GS} = -4.5V$, $V_{DS} = -10V$, $I_D = -4A$	
Gate-Drain Charge	Q_{gd}	_	1.7	_	nC		
Turn-On Delay Time	t _{D(on)}	_	80.4	160	ns		
Turn-On Rise Time	t _r	_	155.1	210	ns	$V_{DS} = -10V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t _{D(off)}	_	688.1	1376	ns	$R_D = 2.5\Omega$, $R_G = 3.0\Omega$	
Turn-Off Fall Time	t _f	_	423.8	848	ns		

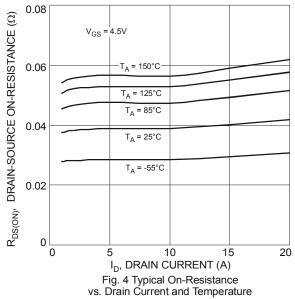
Notes:

- 6. Device mounted on FR-4 PCB with minimum recommended pad layout.
 7. Repetitive rating, pulse width limited by junction temperature.
 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to production testing.









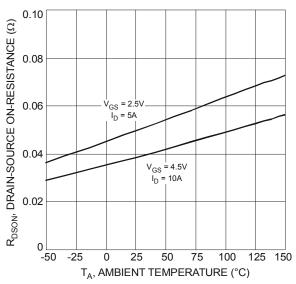
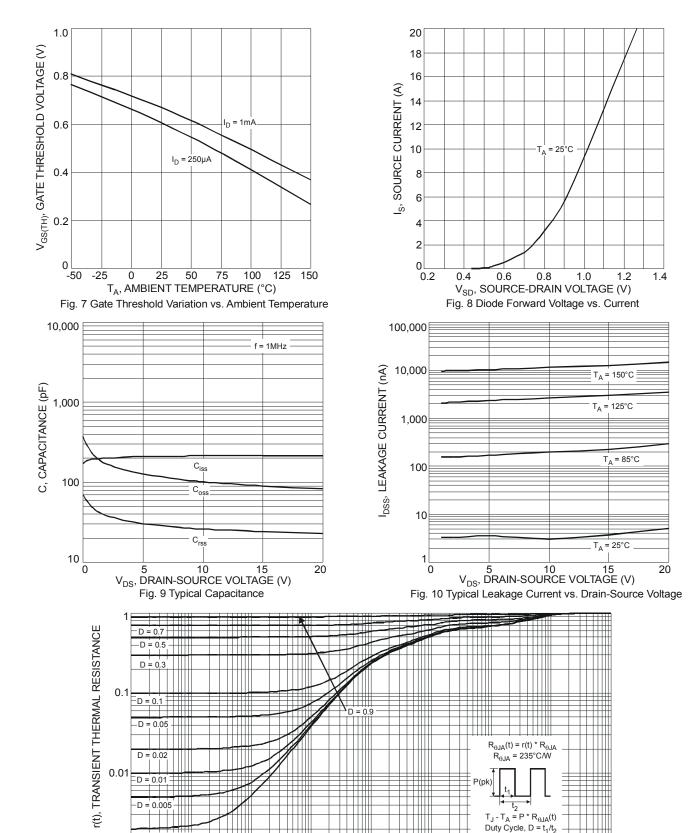


Fig. 6 On-Resistance Variation with Temperature





t₁, PULSE DURATION TIME (s) Fig. 11 Transient Thermal Response

0.1

10

100

1,000

0.001

0.0001

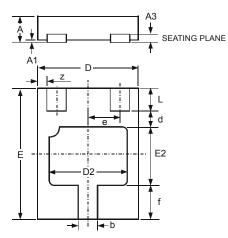
0.001

0.01



Package Outline Dimensions

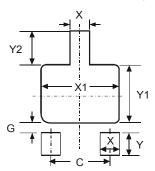
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



X2-DFN2015-3							
Dim	Min	Max	Тур				
Α	_	0.40	-				
A1	0	0.05	0.02				
A3	_	_	0.13				
b	0.20	0.30	0.25				
d	_	_	0.30				
D	1.45	1.575	1.50				
D2	1.00	1.20	1.10				
е	_	_	0.50				
Е	1.95	2.075	2.00				
E2	0.70	0.90	0.80				
f	_	_	0.60				
L	0.25	0.35	0.30				
Z	_	_	0.125				
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	1.00
G	0.15
X	0.31
X1	1.30
Υ	0.50
Y1	1.00
Y2	0.65



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